

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination ADHIKARI ET AL.	
		Examiner Vivek D. Koppikar	Art Unit 3626	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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FOREIGN PATENT DOCUMENTS

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	N	JP 08-314727	11-1996	Japan	Tanaka et al.	G06F009/45
	O					
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NON-PATENT DOCUMENTS

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